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•	Members of the Texas Instruments <i>Widebus™</i> Family	SN54ABT16853 WD PACKAGE SN74ABT16853 DGG OR DL PACKAG (TOP VIEW)	E
•	State-of-the-Art <i>EPIC</i> -II <i>B</i> ™ BiCMOS Design Significantly Reduces Power Dissipation		
•	Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17	1LE 2 55 1CLR 1ERR 3 54 1PARITY	
•	Typical V _{OLP} (Output Ground Bounce) < 1 V at V _{CC} = 5 V, T _A = 25°C	GND 4 53 GND 1A1 5 52 1B1	
•	Distributed V _{CC} and GND Pin Configuration Minimizes High-Speed Switching Noise	1A2 6 51 1B2 V _{CC} 7 ⁵⁰ V _{CC}	
•	Flow-Through Architecture Optimizes PCB Layout	1A3 8 49 183 1A4 9 48 184 1A5 10 47 185	
•	High-Drive Outputs (–32-mA I _{OH} , 64-mA I _{OL})	1A5 10 47 1B5 GND 11 46 GND	
٠	Parity-Error Flag With Parity Generator/Checker	1A6 [12 45] 1B6 1A7 [13 44] 1B7	
•	Latch for Storage of the Parity-Error Flag	1A8 🛛 14 43 🗍 1B8	
•	Package Options Include Plastic 300-mil	2A1 🛛 15 42 🖸 2B1	
	Shrink Small-Outline (DL) and Thin Shrink	2A2 16 41 2B2	
	Small-Outline (DGG) Packages and 380-mil	2A3 [] 17 40 [] 2B3 GND [] 18 39 [] GND	
	Fine-Pitch Ceramic Flat (WD) Package Using 25-mil Center-to-Center Spacings	2A4 [] 19 38 [] 2B4	
	Using 25-mil Center-to-Center Spacings	2A5 20 37 2B5	
desc	ription	2A6 21 36 286	
	•	V _{CC} [22 35] V _{CC}	
	The 'ABT16853 dual 8-bit to 9-bit parity	2A7 [] 23 34 [] 2B7	
	transceivers are designed for communication between data buses. When data is transmitted	2A8 24 33 2B8	
	from the A bus to the B bus, a parity bit is	GND 25 32 GND	
	generated. When data is transmitted from the	2ERR 26 31 2PARITY 2LE 27 30 2CLR	

A 9-bit parity generator/checker generates a parity-odd (PARITY) output and monitors the parity of the I/O ports with the ERR flag. The parity-error output can be passed, sampled, stored, or cleared from the latch using the latch-enable (\overline{LE}) and clear (\overline{CLR}) control inputs. When both \overline{OEA} and \overline{OEB} are low, data is transferred from the A bus to the B bus, and inverted parity is generated. Inverted parity is a forced error condition that gives the designer more system diagnostic capability.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.



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B bus to the A bus, with its corresponding parity

bit, the open-collector parity-error (ERR) output indicates whether or not an error in the B data has occurred. The output-enable (\overline{OEA} and \overline{OEB}) inputs can be used to disable the device so that the buses are effectively isolated. The 'ABT16853

provide true data at the outputs.

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description (continued)

The SN54ABT16853 is characterized for operation over the full military temperature range of -55° C to 125° C. The SN74ABT16853 is characterized for operation from -40° C to 85° C.

					FUNC	TION TA	BLE									
INPUTS							OUTPL	JT AND I/O								
OEB	OEA	CLR	LE	ΑΙ Σ ΟF Η	ΒΙ † Σ ΟF Η	А	В	PARITY	ERR‡	FUNCTION						
L	н	х	х	Odd Even	NA	NA	А	L H	NA	A data to B bus and generate parity						
н	L	х	L	NA	Odd Even	В	NA	NA	H L	B data to A bus and check parity						
Н	L	Н	Н	NA	Х	Х	NA	NA	NC	Store error flag						
Х	Х	L	Н	Х	Х	Х	NA	NA	Н	Clear error-flag register						
		Н	Н	Х					NC							
н	н	L	Н	Х	х	7	z	Z	Н	Isolation§						
	п	Х	L	L Odd			Z Z	Ζ Ζ	Ζ Ζ	Z Z						(parity check)
		Х	L	H Even					L							
L	L	х	Х	Odd Even	NA	NA	A	H L	NA	A data to B bus and generate inverted parity						

NA = not applicable, NC = no change, X = don't care

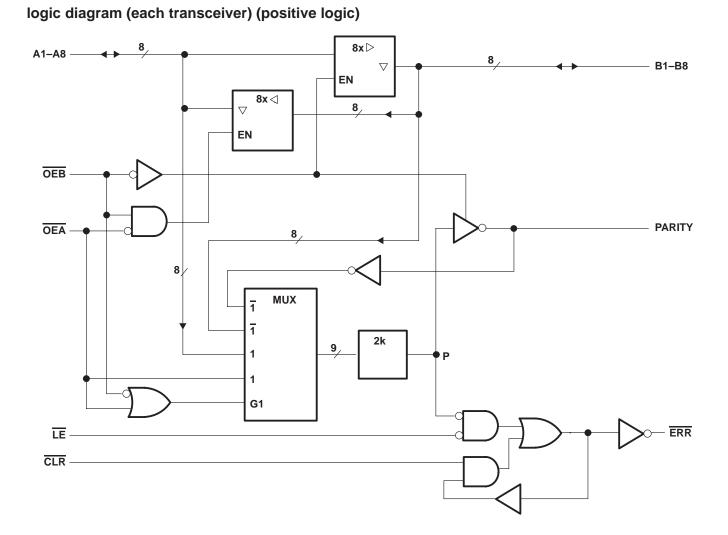
[†] Summation of high-level inputs includes PARITY along with Bi inputs.

[‡]Output states shown assume ERR was previously high.

§ In this mode, ERR (when clocked) shows inverted parity of the A bus.



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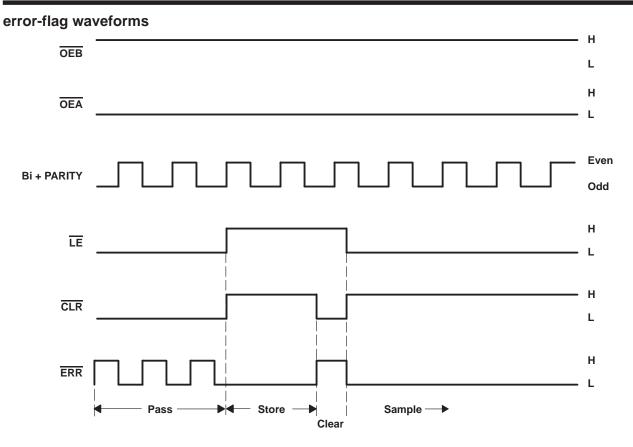
ERROR-FLAG FUNCTION TABLE

INPU	JTS	INTERNAL TO DEVICE	OUTPUT		FUNCTION
CLR	LE	POINT P	ERR _{n-1} †	EKK	
		L	х	L	Pass
	L	Н	Λ	Н	1 835
		L	Х	L	
н	L	Х	L	L	Sample
		Н	Н	Н	
L	Н	Х	Х	Н	Clear
н	н	х	L	L	Store
пп		^	Н	Н	3.016

[†]State of ERR before changes at CLR, LE, or point P



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC}	–0.5 V to 7 V
Input voltage range, V _I (except I/O ports) (see Note 1)	–0.5 V to 7 V
Voltage range applied to any output in the high or power-off state, Vo	–0.5 V to 5.5 V
Current into any output in the low state, I _O : SN54ABT16853	96 mA
SN74ABT16853	128 mA
Input clamp current, I _{IK} (V _I < 0)	–18 mA
Output clamp current, I _{OK} (V _O < 0)	
Package thermal impedance, θ _{JA} (see Note 2): DGG package	81°C/W
DL package	
Storage temperature range, T _{stg}	–65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51.



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recommended operating conditions (see Note 3)

			SN54AB	Г16853	SN74AB	Г16853	UNIT
			MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage		4.5	5.5	4.5	5.5	V
VIH	High-level input voltage		2	N	2		V
VIL	Low-level input voltage			0.8		0.8	V
VI	Input voltage		0	Vcc	0	VCC	V
VOH	High-level output voltage	ERR	6	5.5		5.5	V
ЮН	High-level output current	Except ERR	20	-24		-32	mA
IOL	Low-level output current		00	48		64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	Outputs enabled	Q	10		10	ns/V
ТА	Operating free-air temperature		-55	125	-40	85	°C

NOTE 3: Unused pins (input or I/O) must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DA		TEST COL	DITIONS	Т	A = 25°C	;	SN54AB	Г16853	SN74AB1	Г16853	UNIT
PP		TEST CO	NDITIONS	MIN	TYP†	MAX	MIN	MAX	MIN	MAX	UNIT
٧IK		V _{CC} = 4.5 V,	lj = -18 mA			-1.2		-1.2		-1.2	V
		V _{CC} = 4.5 V,	I _{OH} = -3 mA	2.5	3		2.5				
Vou	All outputs	V _{CC} = 5 V,	I _{OH} = -3 mA	3	3.4		3		3		V
VОН	VOH except ERR	V _{CC} = 4.5 V	I _{OH} = -24 mA				2				v
		VCC = 4.5 V	I _{OH} = -32 mA	2*	2.7				2		
VOL		V _{CC} = 4.5 V	I _{OL} = 24 mA		0.25	0.55		0.55			V
VOL		VCC = 4.5 V	I _{OL} = 64 mA		0.3	0.55*				0.55	v
V _{hys}					100			2			mV
IOH	ERR	$V_{CC} = 4.5 V,$	V _{OH} = 5.5 V			20		20		20	μΑ
loff		$V_{CC} = 0,$	VI or VO \leq 4.5 V			±100		351		±100	μA
ICEX	Outputs high	V _{CC} = 5.5 V,	$V_{O} = 5.5 V$			50	6	50		50	μΑ
1.	Control inputs				±1	20	±1		±1		
ł	A or B ports	$V_{CC} = 5.5 \text{ V}, \text{ V}_{I} = V_{CC} \text{ or GND}$				±100	00	±100		±100	μA
۱ _{IL}	A or B ports	V _{CC} = 0,	V _I = GND			-50	40	-50		-50	μΑ
lo‡		V _{CC} = 5.5 V,	V _O = 2.5 V	-50	-100	-180	-50	-180	-50	-180	mA
IOZH§	3	V _{CC} =5.5 V,	V _O = 2.7 V			50		50		50	μΑ
IOZL§		V _{CC} = 5.5 V,	$V_{O} = 0.5 V$			-50		-50		-50	μA
		V _{CC} = 5.5 V,	Outputs high		1.5	2		2		2	
ICC	A or B ports	$I_{O} = 0,$	Outputs low		32	40		40		40	mA
	VI = VCC		Outputs disabled		1	2		2		2	
∆ICC¶	I	$V_{CC} = 5.5 V$, One in Other inputs at V_{CC}				50		50		50	μΑ
Ci	Control inputs	V _I = 2.5 V or 0.5 V			3						pF
Cio	A or B ports	V _O = 2.5 V or 0.5 V	,		9						pF

* On products compliant to MIL-PRF-38535, this parameter does not apply.

[†] All typical values are at $V_{CC} = 5$ V.

[‡]Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

§ The parameters IOZH and IOZL include the input leakage current.

This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.



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timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

			V _{CC} = T _A = 2	⊧ 5 V, 25°C	SN54AB	Г16853	SN74AB1	16853	UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	
+	Pulse duration	LE high or low	8.5		8.5	15	8.5		
tw	Fuise duration	CLR low	4		4	2E	4		ns
+	Sotup time	A, B, and PARITY before $\overline{\text{LE}}\downarrow$			10	2	10		
t _{su}	Setup time	CLR before LE↓	0		9		0		ns
4	Hold time	A, B, and PARITY after $\overline{LE}\downarrow$			0		0		
th		CLR after LE↓	0		\$ 0		0		ns

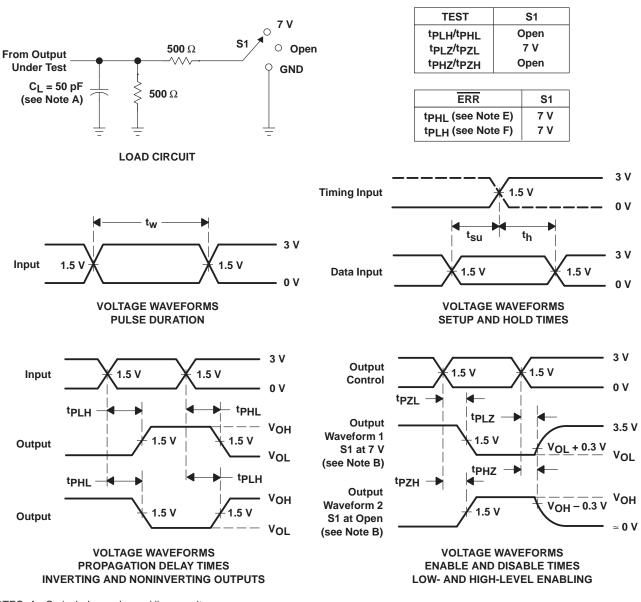
switching characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V(Tj	CC = 5 V A = 25°C	, ;	SN54AB	16853	SN74AB	F16853	UNIT	
		(001101)	MIN	TYP	MAX	MIN	MAX	MIN	MAX		
^t PLH	A or B	B or A	1.5	2.5	3.3	1.5	4.2	1.5	4.1	ns	
^t PHL	AOIB	BUIA	2	3.1	3.9	2	4.5	2	4.3	115	
^t PLH	A or OE	PARITY	2	4.6	5.9	2	7.3	2	7.1	ns	
^t PHL	A of OE	FANITI	2	4.8	6.2	2	7.6	2	7.2	115	
^t PLH	CLR	ERR	2	3.7	5.1	2	5.9	2	5.7	ns	
^t PZH		A or B	2	3.9	4.9	2	5.8	2	5.6		
^t PZL	OE	AOIB	2.5	4.3	5.1	2.5	6.2	2.5	6	ns	
^t PHZ	OF A or B		2	3.6	4.5	2	5.5	2	5.4	ns	
^t PLZ	OE	AUB	1.5	3	3.8	1.5	4.7	1.5	4.3	115	
^t PZH	OE	PARITY	2	3.6	5	2 2	5.8	2	5.7	ns	
^t PZL	ÛE	FANIT	2.5	4.4	5.8	2.5	6.7	2.5	6.5	115	
^t PHZ	OE	PARITY	1.5	3.2	4	1.5	4.8	1.5	4.7	ns	
^t PLZ	ÛE	FANITI	1.5	2.9	3.7	1.5	4.2	1.5	4.1	115	
^t PLH	LE	ERR	2	3.5	4.2	2	5	2	4.8	ns	
^t PHL	LE	ERR	2	3.4	4.4	2	5.2	2	4.9	115	
^t PLH	A, B, or PARITY	ERR		4.5	6.3	2	7.5	2	7.2		
^t PHL		EKK	2	4.8	6.3	2	7.7	2	7.4	ns	

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PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2.5 ns, t_f \leq 2.5 ns.

D. The outputs are measured one at a time with one transition per measurement.

E. tpHL is measured at 1.5 V.

F. tpLH is measured at VOL + 0.3 V.

Figure 1. Load Circuit and Voltage Waveforms



TEXAS NSTRUMENTS

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
74ABT16853DGGRE4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74ABT16853DGGRG4	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT16853DGGR	ACTIVE	TSSOP	DGG	56	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT16853DL	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT16853DLG4	ACTIVE	SSOP	DL	56	20	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT16853DLR	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74ABT16853DLRG4	ACTIVE	SSOP	DL	56	1000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

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Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal												
Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ABT16853DGGR	TSSOP	DGG	56	2000	330.0	24.4	8.6	15.6	1.8	12.0	24.0	Q1
SN74ABT16853DLR	SSOP	DL	56	1000	330.0	32.4	11.35	18.67	3.1	16.0	32.0	Q1



PACKAGE MATERIALS INFORMATION

11-Mar-2008



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ABT16853DGGR	TSSOP	DGG	56	2000	346.0	346.0	41.0
SN74ABT16853DLR	SSOP	DL	56	1000	346.0	346.0	49.0

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